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## PHASE RELATIONSHIPS IN HIGH TEMPERATURE CERAMICS

BY R. P. TURCOTTE (FLOW RESEARCH COMPANY)  
FOR NAVAL SURFACE WEAPONS CENTER  
STRATEGIC SYSTEMS DEPARTMENT

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## FOREWORD

The work described in this report is the result of Phase I Small Business Innovation Research (SBIR) contract funded through the Naval Surface Weapons Center (NSWC), White Oak Laboratory. Mr. Mark Opeka of NSWC was the technical monitor for the project and contributed to its direction.

A number of colleagues in the Advanced Materials Division of Flow Research Company contributed directly to the successful outcome of the study. Glen Moore helped with equipment setup, x-ray, and SEM work. Ender Savrun helped with the carbide work. Art Day designed the environmental chamber/furnace and helped with the laser setup/pyrometry. Brian Walker helped with the laser studies. Birol Sonuparlak provided a critical technical review of the work. Julie Upton and Carole Dennis organized and typed the final report.

Approved by:

D.B. Colby

D. B. COLBY, Head  
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## INTRODUCTION

This report describes results of a Small Business Innovation Research (SBIR) Phase I study of high temperature ceramic systems which could find applications as components in propulsion applications. Since desired use temperatures extend to temperatures as high as 5000°F, there are relatively few materials which are attractive. Thus, carbides and oxides of hafnium, zirconium and tantalum, as well as a few other high melting point ceramics like  $\text{ThO}_2$ , are potentially useful. For a variety of reasons certain binary compounds may be desirable, as might be additions of other dopants (e.g.,  $\text{B}_2\text{O}_3$ ). Unfortunately, very little information is available concerning the high temperature properties of binary and ternary systems of interest. The objective of this work was to establish an efficient means of determining the high temperature phase behavior of such systems under conditions of relevance to their potential use in propulsion system environments. This initial Phase I effort involved study of two related systems,  $\text{HfO}_2/\text{Ta}_2\text{O}_5$  and  $\text{HfC}/\text{TaC}$  with a primary emphasis on the oxides, for which only very limited information has been published. A primary objective was to establish melting temperatures for the mixed oxides and to identify phases formed in the high temperature portions of the phase diagram, above 2500°F (1400°C).

The approaches evaluated included traditional anneal quench studies and use of  $\text{CO}_2$  laser heating in controlled atmospheres. Melting points were measured using an optical pyrometer/laser fusion approach. Phases formed were characterized primarily by x-ray diffraction and electron microscopy. The liquidous curve for the oxide system has been established and two new phases identified for the oxide system. A limited effort on the related carbides will be reported later. Unless otherwise noted all of the work was conducted in air.



## EXPERIMENTAL

## MATERIALS

Starting materials were purchased from Cerac, Inc., with certificates of analysis. X-ray diffraction analysis of all four materials agreed with Powder Diffraction File (PDF) standards with no indication of impurity phases.

Ta<sub>2</sub>O<sub>5</sub> (T-1013) lot #7830, 325 mesh, 99.95% pure,  
major impurities (PPM) as follows:

Nb less than 50  
Mo less than 10  
W less than 10  
Si less than 10

HfO<sub>2</sub> (H-1011) lot #7854, 325 mesh, 99.95% pure,  
major impurities (PPM) as follows:

Zr 1.1%  
Sr less than 100  
Na less than 100  
Zn less than 50

Starting materials were dried at 150°C in quartz crucibles then weighed (+/- 0.1 mg) to give desired mixed compositions. The various compositions were mixed by forming an alcohol slurry, dried and pressed to form pellets 1 cm in diameter x 2 mm thick. The pellets were then heat treated as discussed in the "Results" section. The following compositions were prepared, primarily based on a literature review of related oxide systems which suggested certain compounds might form in the system.

Hf/Ta atom ratio = 20, 10, 6, 4, 2.5, 2, 1, 0.25, 0.167, 0.05

## EQUIPMENT

X-Ray Diffraction - Three different diffractometers were used depending on availability, including Philips (University of Washington), Siemens (Scan Tech, Inc.) and Philips (AMD equipment). In all cases, copper radiation was used. Traces were generally recorded at 1°/2θ/minute on strip chart recorders.

Laser - Photon Sources, Model 305, 500 Watt, TEM<sub>00</sub> mode. In all of the work to be discussed, the laser was operated in the continuous mode rather than pulsed. Although some experiments involved use of a lens to focus the beam, virtually all of the results used the unfocused beam directly, heating the materials from above. The spot size was approximately 0.5 cm<sup>2</sup> and slightly oval shaped based on burn patterns. A chopper was placed in the beam to reduce intensity by a factor of two to four. Power levels were manually set with a ten turn (digital) potentiometer. The typical power levels required in this study ranged from 10 watts to over 500 watts. The laser was upgraded to provide very stable power/beam intensity. We found materials could be reproducibly heated to the same constant temperature over tens of minutes, although this was not really required for the present application.

It is possible to estimate the temperature of a sample heated under a laser beam by considering the energy balance in equilibrium. Energy flows into the sample by absorption of radiation (infrared light) from the laser beam. Energy is lost from the sample by thermal conduction into surrounding contacting materials and also by reradiation. When the sample has reached an equilibrium temperature, the flow of energy into the sample must equal the energy losses to the surroundings. Thermal conductivity losses can be minimized by heating the sample in vacuum on a low thermal conductivity support such as fibrous zirconia. The radiated energy loss can be estimated from Plank's blackbody radiation law and the known sample emissivity. If the sample is spherical with a diameter on the order of the laser beam diameter, then nearly all of the energy of the laser beam will be absorbed. Equating the absorbed energy with the radiated energy and assuming a typical emissivity value of 0.77 yields the temperature vs. diameter curve shown in Figure 1. The temperature rises rapidly as the sample size (and focused beam size) decreases. It should thus be possible to melt any known material with only moderate focusing of the subject laser. This result has been experimentally verified by easily reaching temperatures above 3000°C with the unfocused beam.

The melting studies involved use of small beads, about 1 to 1.5mm in diameter, assuming the small interface region between two contacting beads was at a constant temperature. Certainly there was some temperature gradient (depending on orientation, heat conduction, etc.),

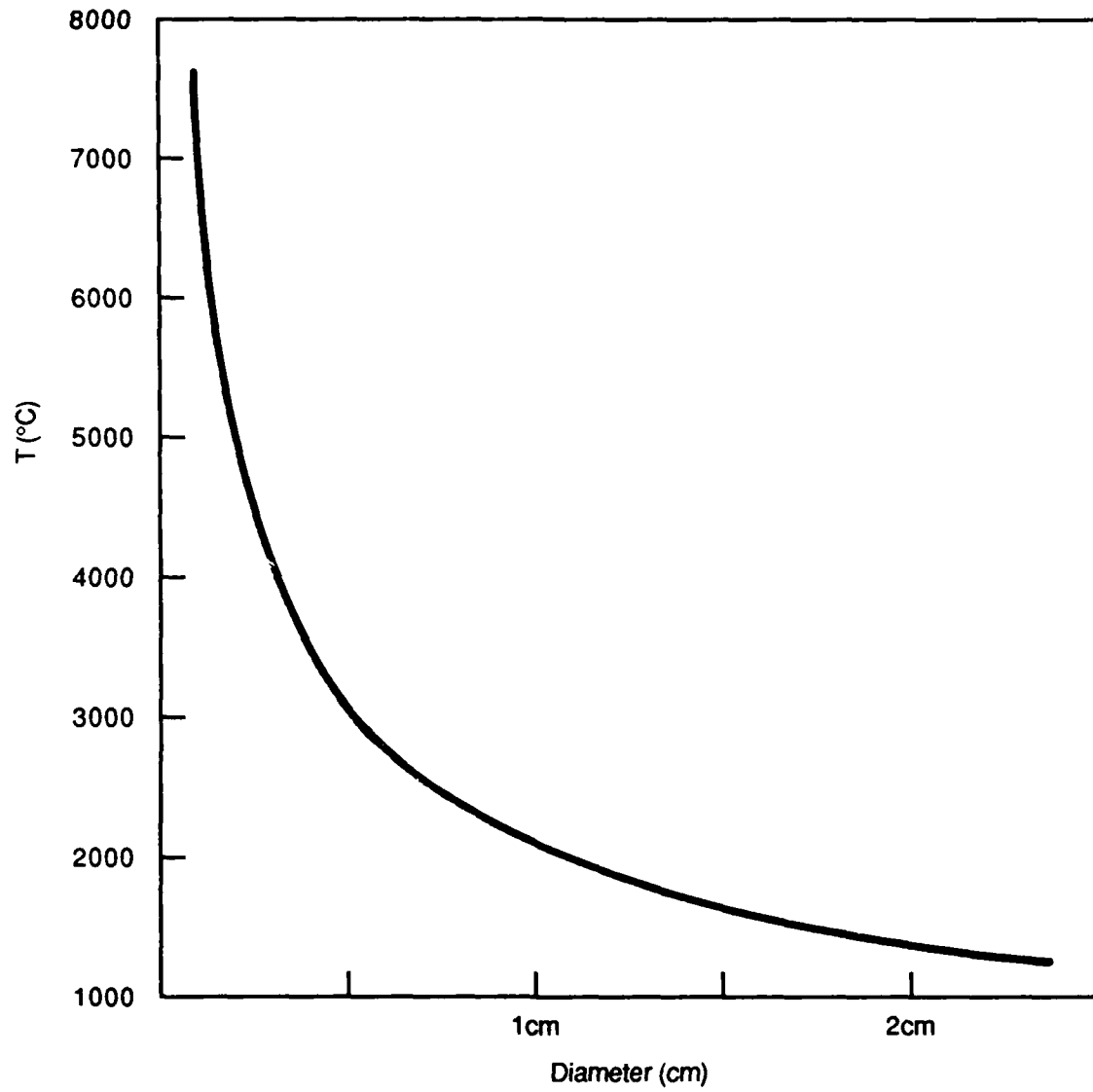


FIGURE 1. MAXIMUM LASER HEATED SURFACE TEMPERATURE  
VERSUS BEAM DIAMETER FOR A 500 WATT LASER

but burn patterns in plastic suggested the center  $1\text{mm}^2$  of the beam was at a nearly flat photon density. The temperature profile was measured on the surface of a low density plate of  $\text{HfO}_2$  as a possible worst case situation. This showed temperatures dropping by almost  $100^\circ\text{C}$  per millimeter from the center, at a temperature of  $1800^\circ\text{C}$  and about  $90^\circ\text{C}$  per millimeter at  $2200^\circ\text{C}$ .

Filament Furnace/Environmental Chamber - A filament vacuum furnace was constructed for use on this project, which also served as a controlled environment chamber in the laser heating experiments. A schematic of the furnace is shown in Figure 2. Small samples could be heated to as high as  $2500^\circ\text{C}$  with tantalum heaters.

With regard to using the chamber with the laser, considerable problems were encountered with destruction of both  $\text{ZnSe}$  and  $\text{NaCl}$  windows. Two focusing lenses ( $\text{Ge}$  and  $\text{ZnSe}$ ) were also destroyed during the course of the project.

Optical Pyrometer - A commercial Land-Minolta optical pyrometer, Cyclops Model 52, was used to measure melting temperatures. This pyrometer has digital readout and automatic emissivity correction features. As discussed in the results section, an emissivity setting of 1.0 and the definition of "melting" as formation of a liquid "neck" between contacting beads gave melting point temperatures for pure  $\text{Ta}_2\text{O}_5$  and pure  $\text{HfO}_2$  in close agreement with the accepted values. Therefore, the data obtained for the mixed oxide compositions are in effect accurate, through direct calibration based on the end member oxides. In general, the reliability and repeatability of the pyrometer readings were observed to be within  $\pm 10^\circ\text{C}$ . Other far more subjective factors discussed later lead to much larger uncertainties in the melting point data.

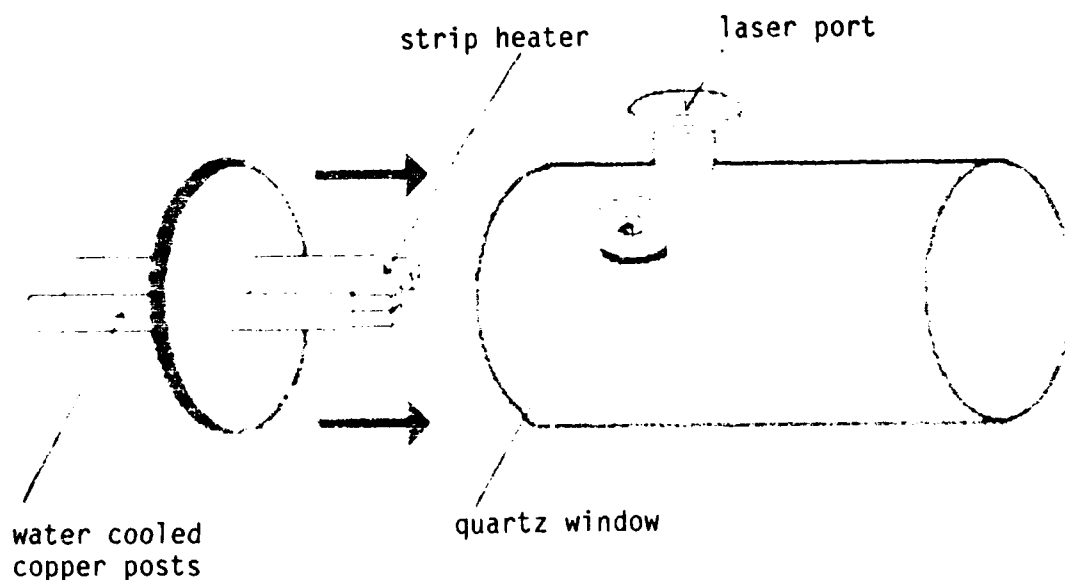


FIGURE 2. SCHEMATIC OF FILAMENT FURNACE/  
LASER ENVIRONMENTAL CHAMBER

Electron Microscopy - A Hitachi Scanning Electron Microscope (Model 570), equipped with energy dispersive x-ray analysis features (Kevex, Model 8005) was used to examine the micro-structures and compositions of the materials studied.

DTA - A commercial Perkin-Elmer DTA/DSC was used with argon cover gas at heating rates of  $10^{\circ}\text{C}/\text{min}$ . The system was used in the DSC mode and calibrated to the correct melting point for gold ( $1063^{\circ}\text{C}$ ).

## RESULTS and DISCUSSION

### MELTING POINT DETERMINATION

Melting points for the mixed oxides were determined by visual observation of millimeter sized beads as the laser intensity was manually increased, in steps giving temperature rises of about  $20^{\circ}\text{C}$ . Initial experiments were conducted to determine the most desirable physical form of the material to evaluate, including various irregular and regular shapes, low vs. high density solids, means of support, etc. An equally difficult question was what to use for emissivity corrections and what definition to apply as identifying the "melting point." It was found that very regular 1-2 millimeter diameter beads

could readily be formed by melting irregular shapes on a large graphite block. Because of its high thermal conductivity, a block 12" in diameter and 6" thick requires 15 minutes or more of direct full power heating before being hot to the touch. Hence, graphite was used to support the materials of interest.

A large number of millimeter size beads of each composition were prepared. A standard arrangement of one bead resting on three beads (or two resting on five or six) was found to give reproducible "melting points" for both  $Ta_2O_5$  and  $HfO_2$  with the pyrometer emissivity set at 1.0. "Melting" was defined as the formation of a liquid "neck" between two adjacent beads, positioned in the beam to give a uniform temperature at the interface. The temperature sensing area, visible as a circle in the pyrometer eyepiece, was smaller than the individual bead whose temperature was being followed as the laser power was increased. The pyrometer was mounted on a tripod and a lens with a 10" focal length was used. Because the beads were originally quenched from the melt, care was taken to gradually increase temperature, giving the material time to approach equilibrium as the melting temperature was approached. An individual melting point was nevertheless determined quite rapidly, within 5-10 minutes. Because the geometry was slightly different in each experiment and adjacent spheres could be at slightly different temperatures, etc., it is easy to recognize that this approach gives rise to considerable scatter as evidenced by the final results, which are shown in Figure 3. The compositions rich in  $Ta_2O_5$  were easier to evaluate since at the melting point, the entire bead would collapse, in contrast to the high hafnia compositions where the beads remained largely solid. It is clear from the figure that the high melting point advantage for pure  $HfO_2$  rapidly falls off with addition of  $Ta_2O_5$ . On that basis alone, it would appear mixed oxides should contain less than 5 mole %  $Ta_2O_5$  for very high temperature applications. The melting point curve for compositions up to 66 mole %  $HfO_2$  is very flat, falling within the range of 1800-2200°C. The data are plotted showing the average value of four or more individual measurements for each composition. The bars drawn represent the observed scatter band. Note the measured average melting point values were 1903°C for  $Ta_2O_5$  and 2822°C for  $HfO_2$ , in reasonable agreement with literature values of 1887°C and 2800-2900°C respectively.

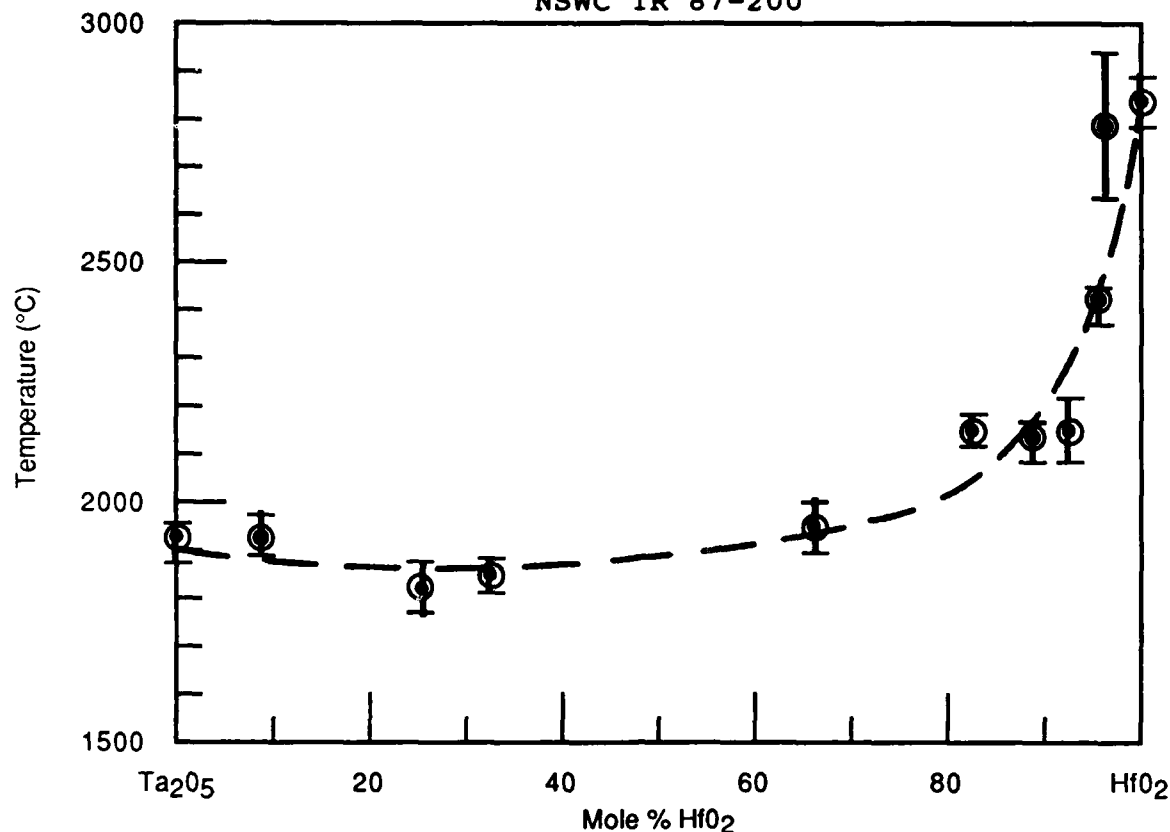


FIGURE 3. MELTING POINTS FOR MIXED  $\text{HfO}_2/\text{Ta}_2\text{O}_5$  OXIDES

#### PHASE BEHAVIOR STUDIES

A series of initial experiments was undertaken to determine whether the pure oxides were sufficiently reactive that simple mixing and pressing into pellets followed by a high temperature treatment could give results which might be taken as near the equilibrium condition. The very high cost and 90-day delivery time for alkoxides of these elements precluded using a molecular mixing approach which would be most desirable. Although it was determined that tantalum oxide is entirely consumed in reaction with  $\text{HfO}_2$  after a few minutes heating at  $1500^\circ\text{C}$ , the results of the study are sufficiently complex that this issue should be reconsidered in further studies. In any case, various series of heat treated samples of the mixed oxide compositions were studied involving: 1) melt quenching, 2)  $1900^\circ\text{C}$  quench, 3)  $1500^\circ\text{C}$ ,  $20^\circ\text{C}/\text{minute}$  cooldown, 5) diffusion couple samples, 6) volatility, 7) differential thermal analysis. Series 1 and 2 were prepared using laser heating. For series 2, pellets which had previously been heated to  $1500^\circ\text{C}$  for several hours were subjected to surface heating at about  $1900^\circ\text{C}$ . For series 3, pellets of the mixed oxide composition were heated at  $400^\circ\text{C}/\text{hr}$  to  $1500^\circ\text{C}$ , held one hour and then physically removed (alumina crucibles were used). For series 4, samples were heated to  $1500^\circ\text{C}$  at  $100^\circ\text{C}/\text{hr}$  and cooled at  $20^\circ\text{C}/\text{minute}$  to  $700^\circ\text{C}$ , at which temperature they were removed from the furnace.

An additional attempted heat treatment to 1700°C resulted in extensive reaction of the materials (especially high Ta<sub>2</sub>O<sub>5</sub> compositions) with the alumina crucible. These were not analyzed.

The results of the phase formation study at this point cannot be entirely interpreted, partly because we have emphasized temperatures above 1500°C, whereas all of the work reported on related studies really is representative of lower temperatures below 1500°C. The review of previous work suggested possible formation of a number of compounds, as shown in Figure 4. The compositions of these phases naturally led to the choice of compositions chosen for study in the program. Our study has identified a new phase which occurs in quenched liquids and the phase with composition 2HfO<sub>2</sub>·Ta<sub>2</sub>O<sub>5</sub> (Hf<sub>2</sub>Ta<sub>2</sub>O<sub>9</sub>) is shown to be especially important as a phase boundary. It should be noted in Figure 4 that there is no information actually available concerning the temperature range of stability for the various compounds identified. Figure 5 shows diffraction patterns for some of the key phases in the system which will allow the reader to better understand the actual x-ray diffraction traces presented later. It should be clear from Figure 5 that patterns resulting from mixtures of phases in the system can be very challenging to separate because of the overlapping of many reflections. This difficulty is further compounded with regard to elemental analysis of crystallites using the electron microscope because of all the fluorescence peaks for Hf and Ta are strongly overlapped. A resolution to most of these analytical difficulties has been achieved in the initial study, but additional work is needed to understand the solid state structures.



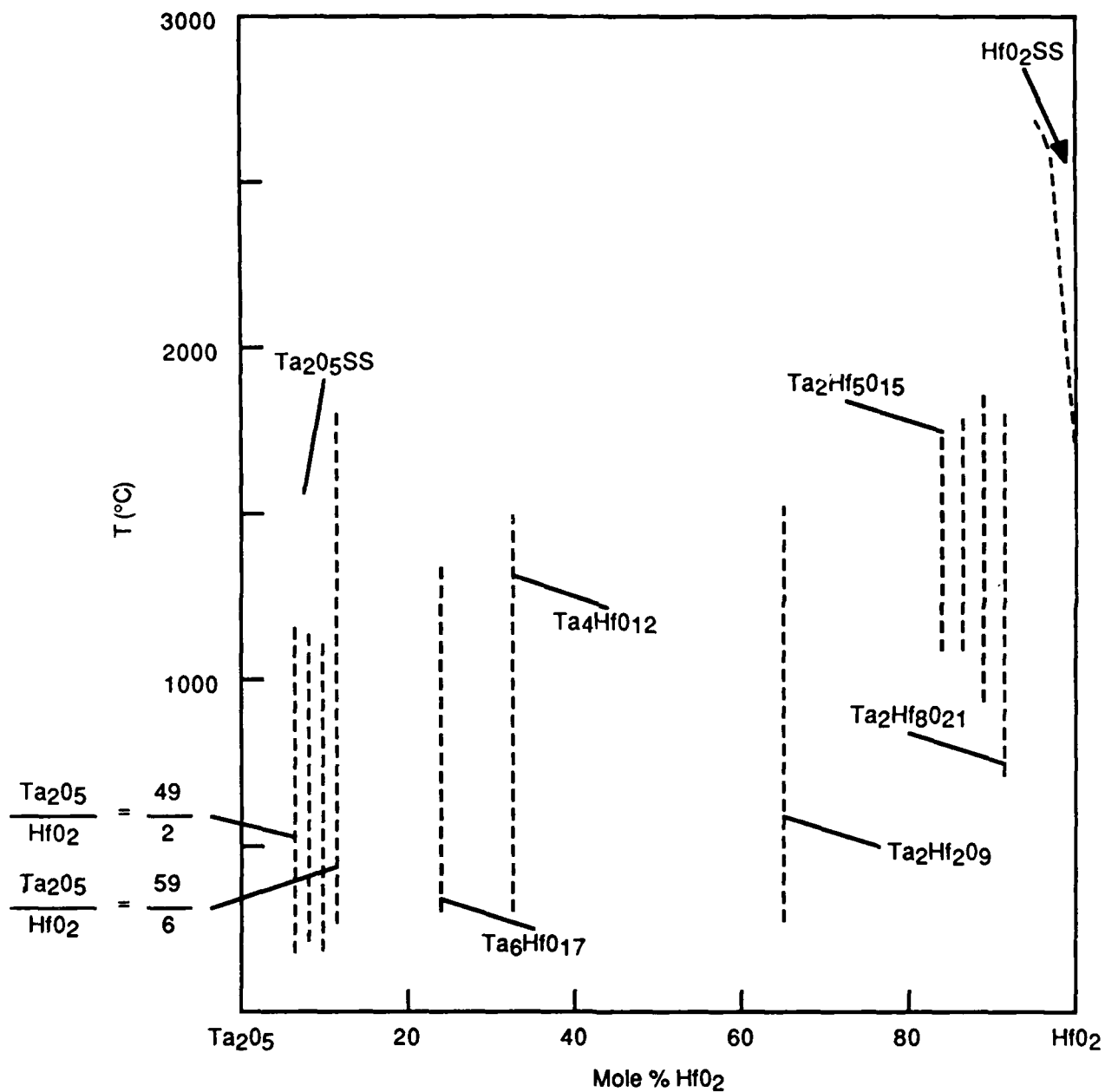


FIGURE 4. HYPOTHETICAL PHASES IN THE  $\text{HfO}_2$ - $\text{Ta}_2\text{O}_5$  System

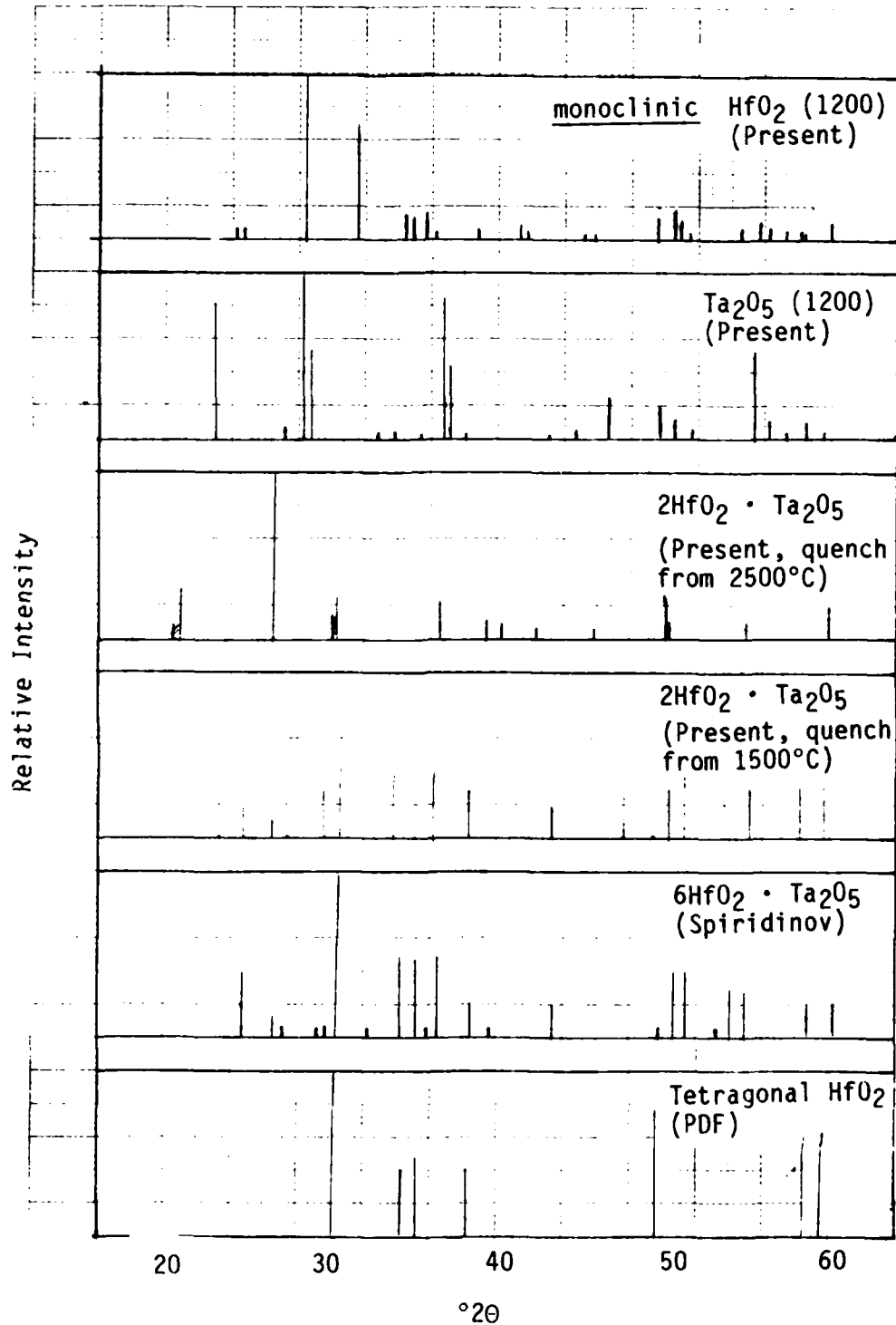


FIGURE 5. X-RAY DIFFRACTION PATTERNS OF KEY PHASES

## Melt Quenching

Beads of molten oxides were quenched from 2000°C or higher and studied by x-ray diffraction and by electron microscopy. Additional samples of larger surface areas were prepared by surface melting portions of pressed pellets to improve x-ray diffraction sensitivity. These were polished to ensure the data represented the bulk liquid rather than the immediate surface.

**X-Ray Diffraction** - Traces are shown in Figure 6. They are immediately striking because the two strongest reflections (and many others) occur for every composition. It may be noted that several of the samples studied ( $\text{Hf/Ta} = 2.5, 10, 6$ ) had small surface areas compared to the others and required using higher sensitivity. The broad band near  $25^\circ 2\theta$  for the 2.5 ratio composition is from the mounting clay used to support the sample. In any case, it appears that mainly one phase is present from  $\text{Hf/Ta} = 20$  to  $\text{Hf/Ta} = 1$ , whereas the remaining high Ta compositions contain at least two major phases. These patterns have not been indexed yet.

**Electron Microscopy** - Electron Microscopy of the liquid quenched materials was also very interesting, but does not correlate well to the above XRD results. Representative micrographs are shown in Figure 7. Five of the eight mixed oxides showed some form of two-phase structure, mainly as an obvious residual frozen liquid seen in higher volume fraction for intermediate compositions like  $\text{Hf/Ta} = 2.5$  and much less at high Hf or very high Ta compositions. As will be discussed, this residual liquid phase is rich in Ta compared to the primary phase. Most of the quenched samples also contained considerable large porosity, concentrated toward the center of the beads. This was expected since the volume change on melting ceramics is often more than 5%. As the beads solidify from the outside-inward, some porosity must develop.

The quantitative analysis of Hf and Ta with the energy dispersive spectrometer (EDS) equipment is not easy because these elements are adjacent in the periodic table (atomic number 72 and 73) and their x-ray fluorescence characteristic spectra overlap extensively. Figures 8 and 9 show typical spectra. For Figure 8, the atomic ratio was  $\text{Hf/Ta} = 6.0$ . For Figure 9, the ratio was  $\text{Hf/Ta} = 0.17$  or  $\text{Ta/Hf} = 5.9$ . It is evident that the software does a good job of identifying the various fluorescence peaks, but they are not resolved. We were nevertheless able to calibrate the equipment to allow fairly accurate elemental analysis. The L series lines in the region 7 to 10.1 keV were used. The Kevex software automatically goes through a curve fitting process to generate apparent concentrations. By using all of the fluorescence coming from a general area view (rather than a spot

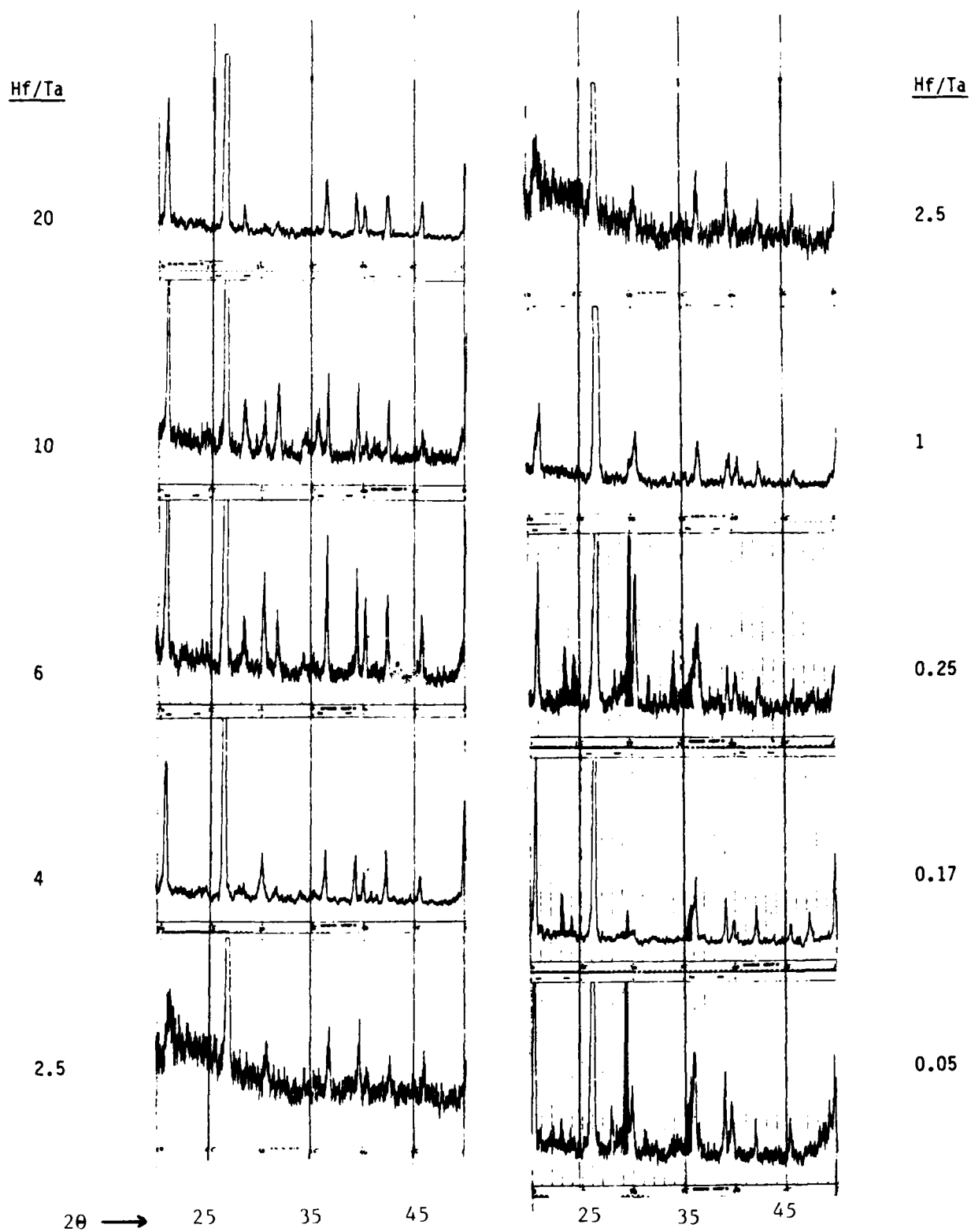


FIGURE 6. X-RAY PATTERNS OF QUENCHED LIQUIDS

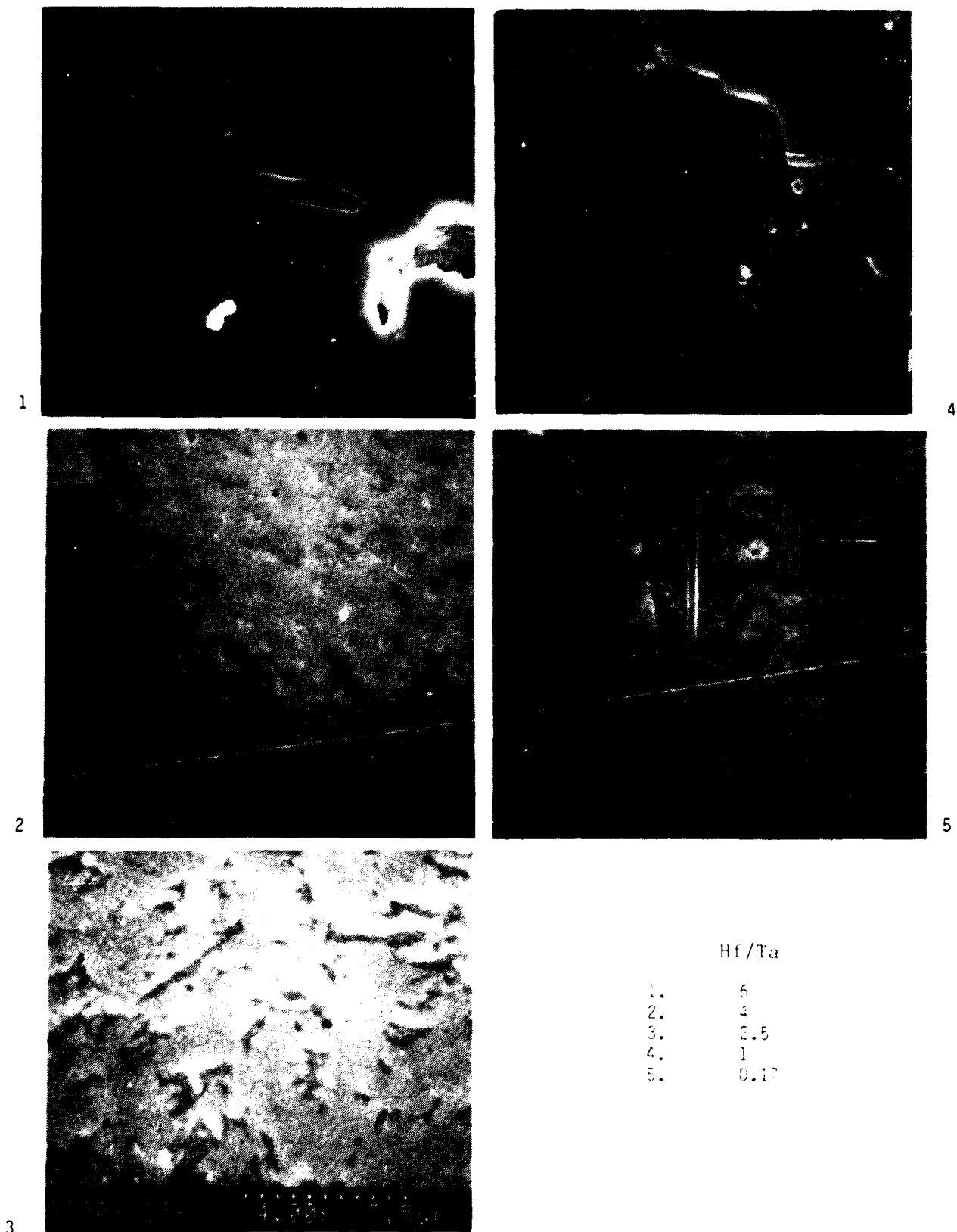


FIGURE 7. ELECTRON MICROGRAPHS (4000X)  
OF QUENCHED LIQUIDS

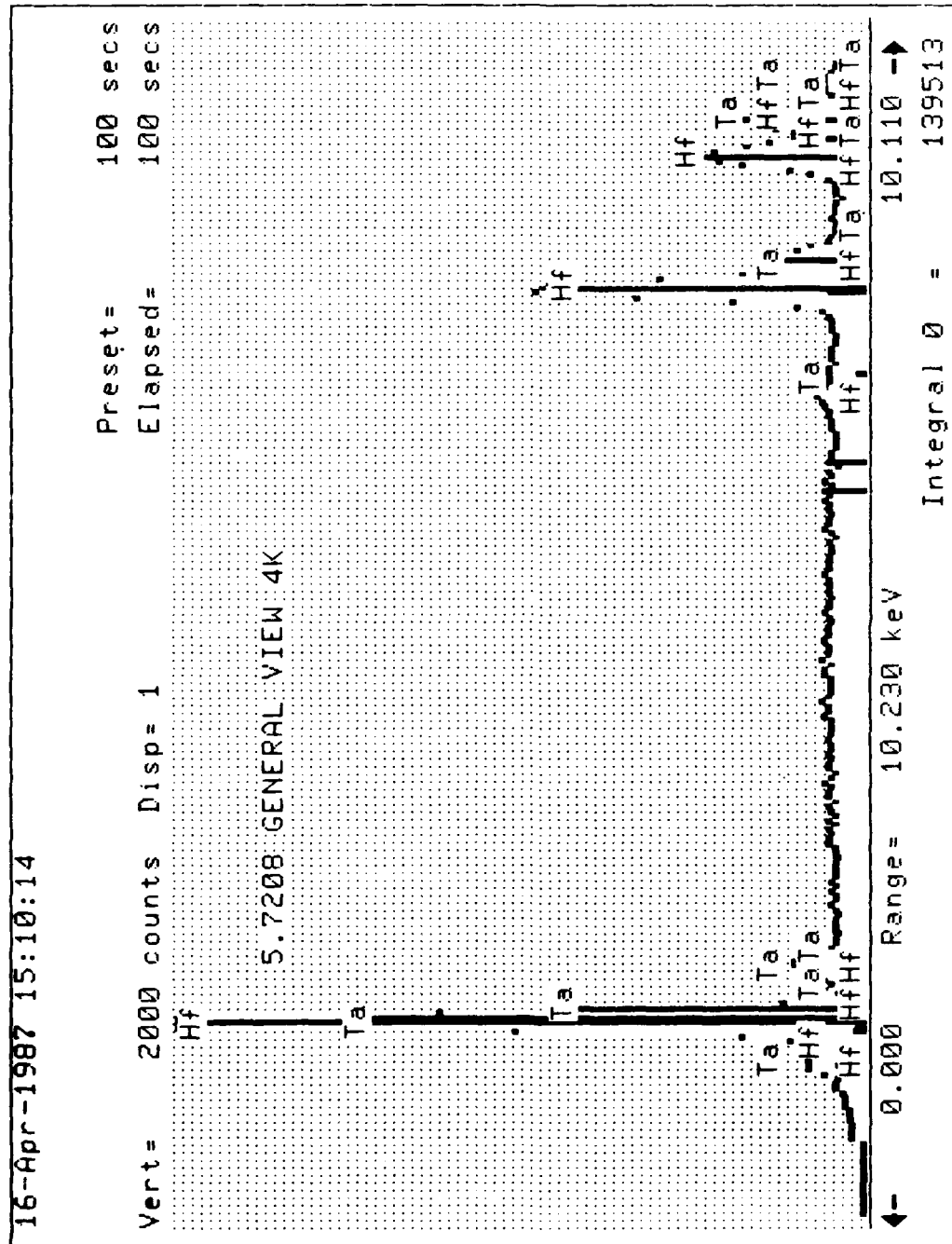


FIGURE 8. EDS SPECTRA OF Hf RICH MIXED OXIDE

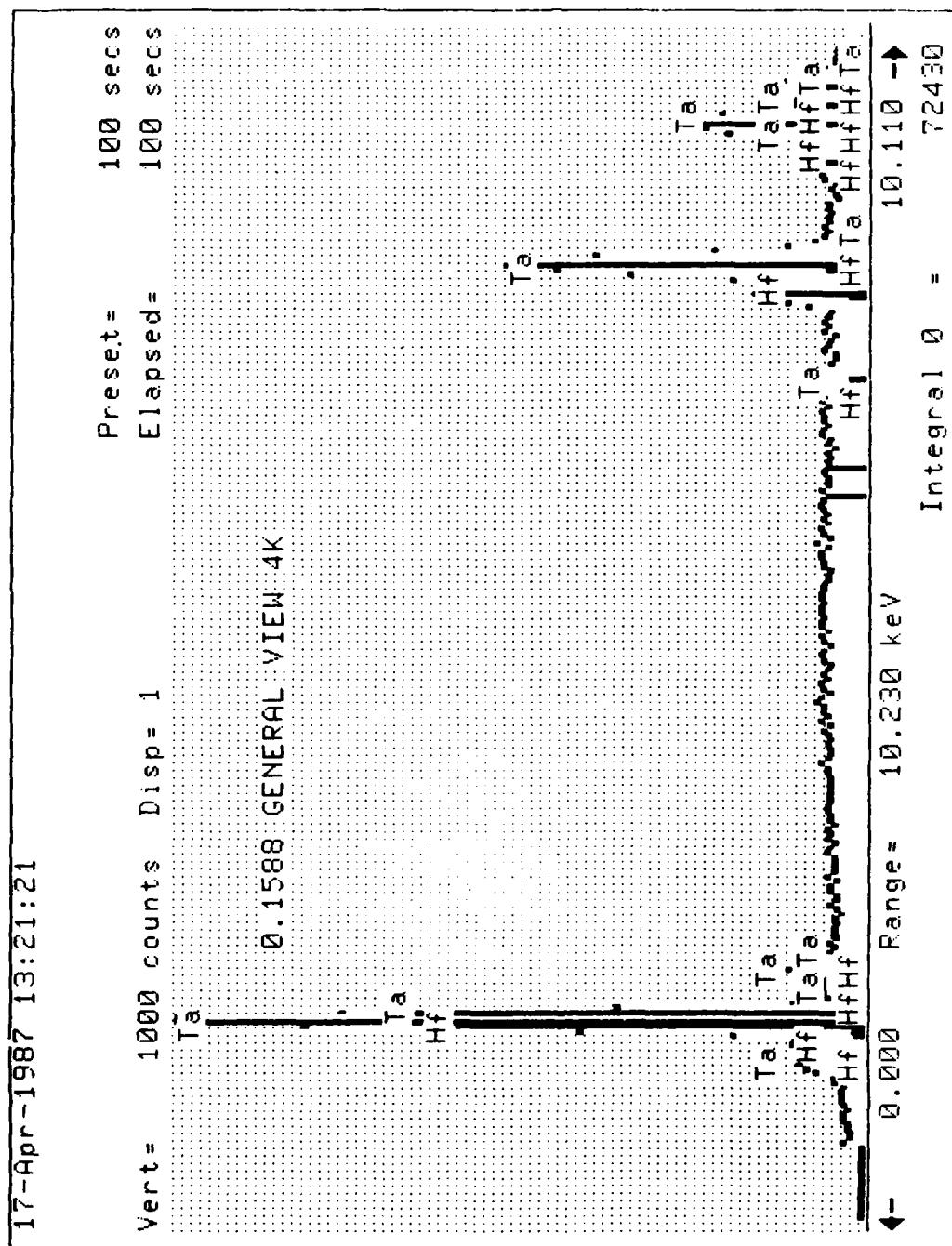


FIGURE 9. EDS SPECTRA OF Ta RICH MIXED OXIDE

count), the average composition of each sample was measured and plotted against the actual "as prepared" composition. Figure 10 shows the correlation of the measured (ZAF) atomic ratio to the actual values. The dashed line shows the "no error" correlation. As might be expected, the measured values are quite accurate near  $Hf=Ta$ .

At high concentrations, the software over-corrects for the presence of Ta indicating much higher Ta concentrations than actually exist. The reverse is true for high Ta compositions, where higher than real Hf concentrations are measured. In any case, by using this calibration curve, accurate Hf/Ta analyses are possible.

Each of the five compositions showing diphasic microstructure was quantitatively studied, with regard to the composition of the high Ta (softer, residual liquid) phase versus the Hf rich phase. The analytical results are summarized in Figure 11 where the composition of the two phases present is plotted versus the average composition of the sample. The dotted line shows the relationship which would occur if no phase separation occurred and a homogeneous solid solution formed. Instead, for example, at average  $Hf/Ta = 1.0$ , a residual liquid-like phase with  $Hf/Ta = 0.20$  and a Hf rich phase with  $Hf/Ta = 2.7$  form. At  $Hf/Ta = 6$ , the two phases have compositions  $Hf/Ta = 1.7$  and  $Hf/Ta = 15.4$ . As shown, there is a dramatic shift in behavior between the composition at  $Hf/Ta = 4$  compared to  $Hf/Ta = 2.5$ . It should be pointed out that for samples with ratios 4 and 6, the volume fraction of the Hf rich phase is relatively small. Thus, the primary phase present in the four compositions with ratios 1, 2.5, 4, 6 has a composition ratio of Hf/Ta in the range 2-3. This may explain some of the lack of variance observed in the x-ray diffraction patterns of Figure 6, but the correlation of the x-ray diffraction and phase analysis data would require much further study.



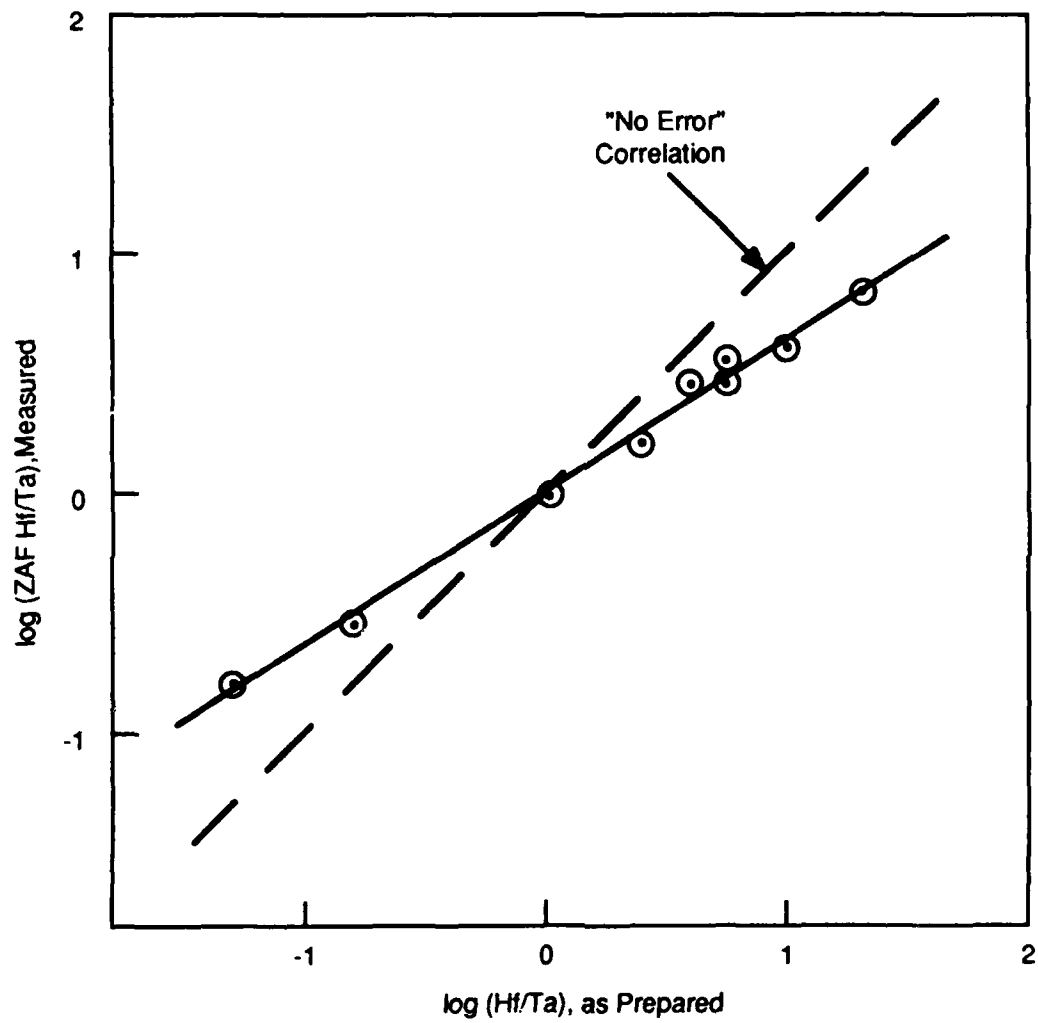


FIGURE 10. EDS CALIBRATION CURVE

The general result observed (Figure 11) is consistent with our expectations as a given composition cools through the liquid-solid diphasic region of the phase diagram, as shown schematically in Figure 12. As liquid of composition y cools to point x, a solid phase rich in  $\text{HfO}_2$  can form, leaving a liquid phase rich in  $\text{Ta}_2\text{O}_5$ . The resulting mixture of solid phases is thus highly dependent on quench rates, the detailed shape of the liquidus-solidus curves and the underlying stability of the various crystalline phases which may form.

#### 1900°C Quench

Pellets which had previously been furnace annealed at 1500°C were surface treated with the laser to temperatures about 1900°C. This involved moving the samples in the beam for a few minutes to repetitively heat sections of the surface to the 1900°C temperature. (The beam covered about 1/4 of the pellet area). The x-ray patterns obtained are shown in Figure 13. At  $\text{Hf}/\text{Ta} = 20$ , the pattern is essentially that of monoclinic  $\text{HfO}_2$ . At  $\text{Hf}/\text{Ta} = 1$ , the pattern is essentially pure  $\text{Hf}_2\text{Ta}_2\text{O}_9$ , with orthorhombic symmetry. The four compositions in between are mixtures of these two phases. The relative proportions of each phase have not been estimated, but the trends are not as clear as observed at 1500°C, discussed in the next section.

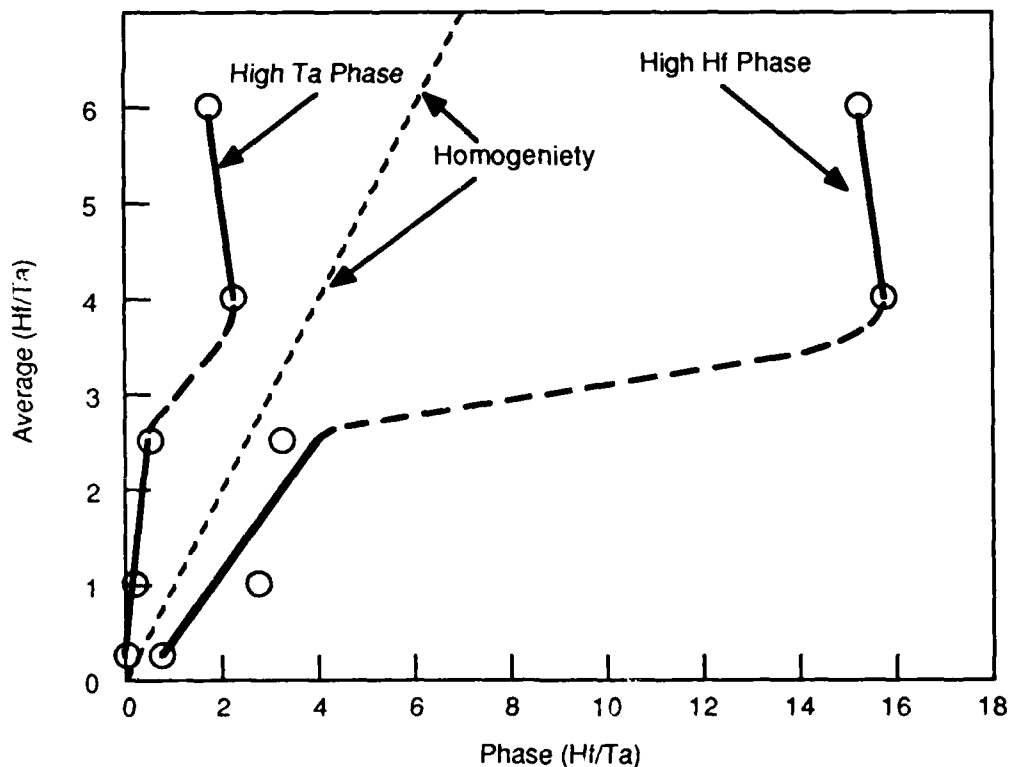


FIGURE 11. COMPOSITION OF TWO PHASES PRESENT IN QUENCHED LIQUIDS

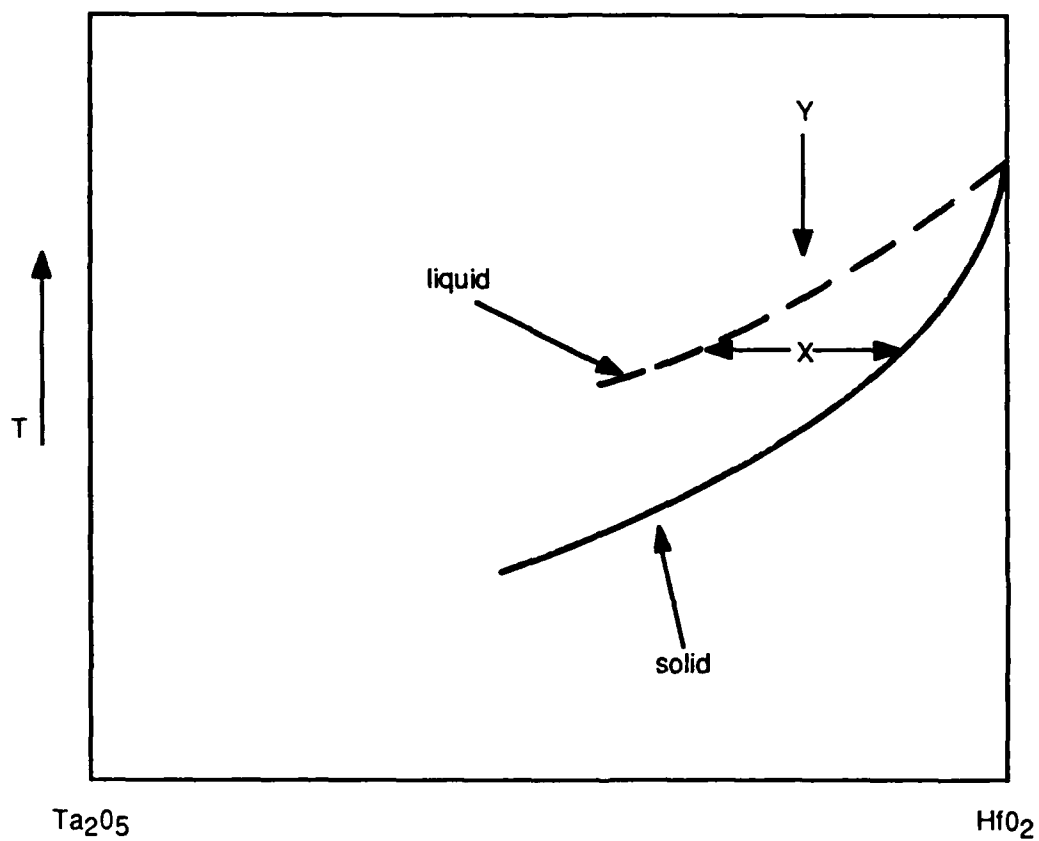


FIGURE 12. SCHEMATIC OF COOLING PATH

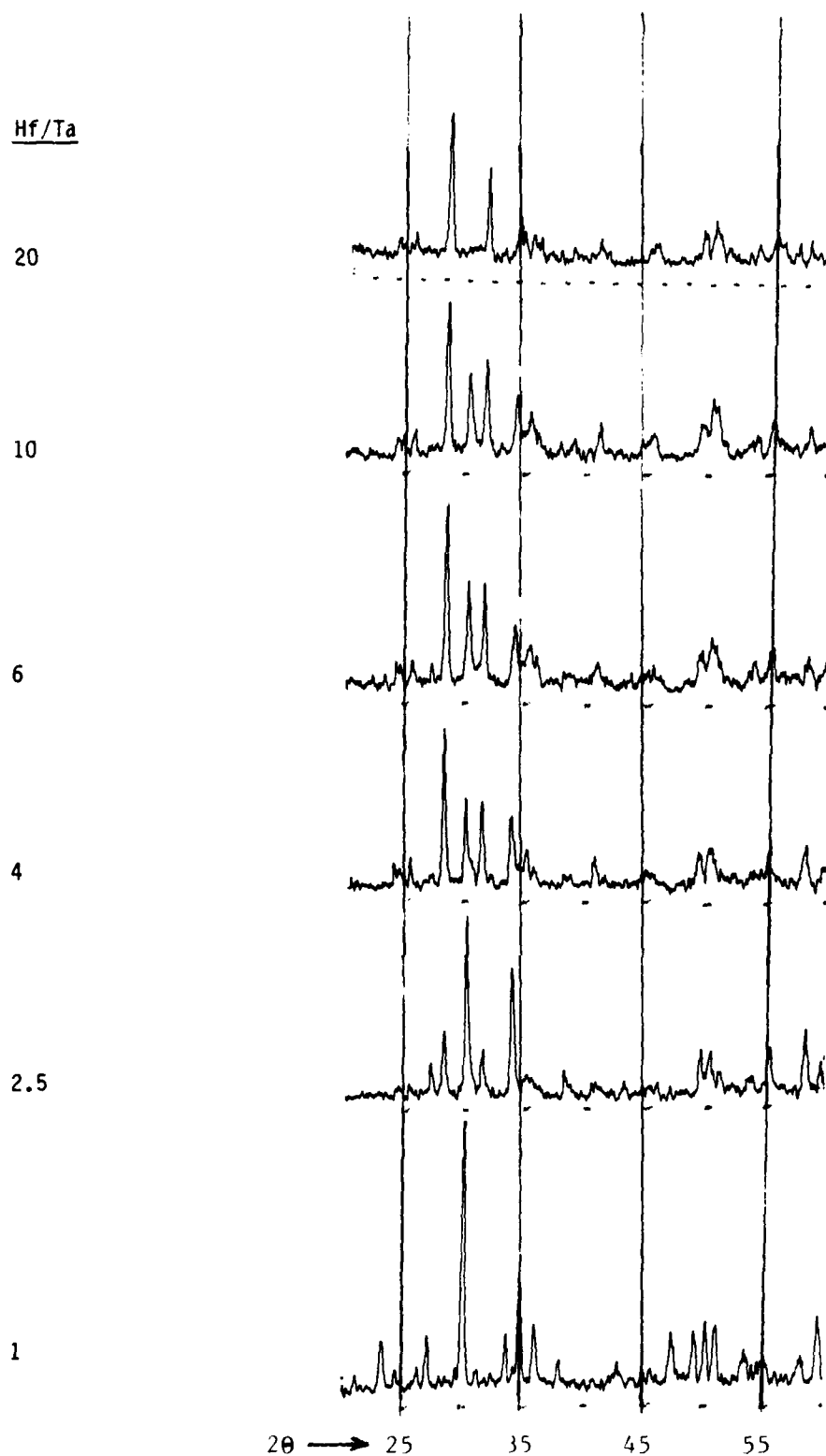


FIGURE 13. XRD TRACES OF SAMPLES  
QUENCHED FROM 1900°C

There were two objectives of this experiment. The first was to see if the primary phase observed after quenching melts (Figure 6) could be achieved by solid state reaction. There is no evidence this phase has formed. The second objective was to increase confidence that the information obtained at lower temperatures was not a result of incomplete reaction of the starting materials. Since the results support the 1500°C data, we conclude that the region from  $\text{Hf}_2\text{Ta}_2\text{O}_9$  to  $\text{HfO}_2$  is probably a diphasic mixture of these phases at least from 1500°C to near melting temperatures. Long term annealing experiments and preparation of the mixed oxides by better molecular mixing are required to prove this observation.

#### 1500°C Quench

Samples quenched from 1500°C by removal from a box furnace gave the x-ray diffraction patterns shown in Figure 14. Near 30° (2θ), three strong diffraction peaks systematically change as the composition changes from  $\text{Hf}/\text{Ta} = 20$  to  $\text{Hf}/\text{Ta} = 1$ . The peak at 30° (2θ) is from the  $\text{Hf}_2\text{Ta}_2\text{O}_9$  phase. The peaks at 28 and 32° (2θ) are from monoclinic  $\text{HfO}_2$ . It is obvious one phase is simply replacing the other in a fairly systematic manner. A rough estimate of relative phase concentrations was made from the relative peak heights of the two phases. To do this, the two primary peaks for  $\text{HfO}_2$  were summed and compared to the reflection from the  $\text{Hf}_2\text{Ta}_2\text{O}_9$  phase. (The reason for this choice was simply that this ratio is approximately true in comparing the pure phases.) Table 1 shows the estimated concentrations of  $\text{Hf}_2\text{Ta}_2\text{O}_9$  in each of the six compositions. The results are very close to the maximum concentrations calculated assuming simple diphasic mixtures exist. We conclude that is the case.

It was pointed out earlier that the diffraction pattern of the  $\text{Hf}_2\text{Ta}_2\text{O}_9$  phase closely resembles the pattern reported by Spiridonov<sup>1</sup> for a series of mixed oxides with much higher Hf content. These workers also report a systematic shift of the position of the diffraction peaks as the composition changes. In these samples, we see no line shifts, suggesting that stoichiometry is fixed at  $\text{Hf}_2\text{Ta}_2\text{O}_9$ . Additional work is required to confirm this result.

#### 1500°C Furnace Cool

A second series of samples was taken through an annealing cycle involving longer times at temperature and cooling at 20°C/minute. The x-ray diffraction results shown in Figure 15 are essentially the same as already discussed for samples quenched from 1500°C. This suggests that the formation of ordered phases reported by Spiridonov

1. Spiridonov, F.M. Mullenkova, M.N., Tsirelnikov, U.L., and Komissarova, L.N. "Intermediate Phases in the Hafnium dioxide-Tantalum pentoxide System," Russian J. of Inorg. Chem. 26 922 (1981)

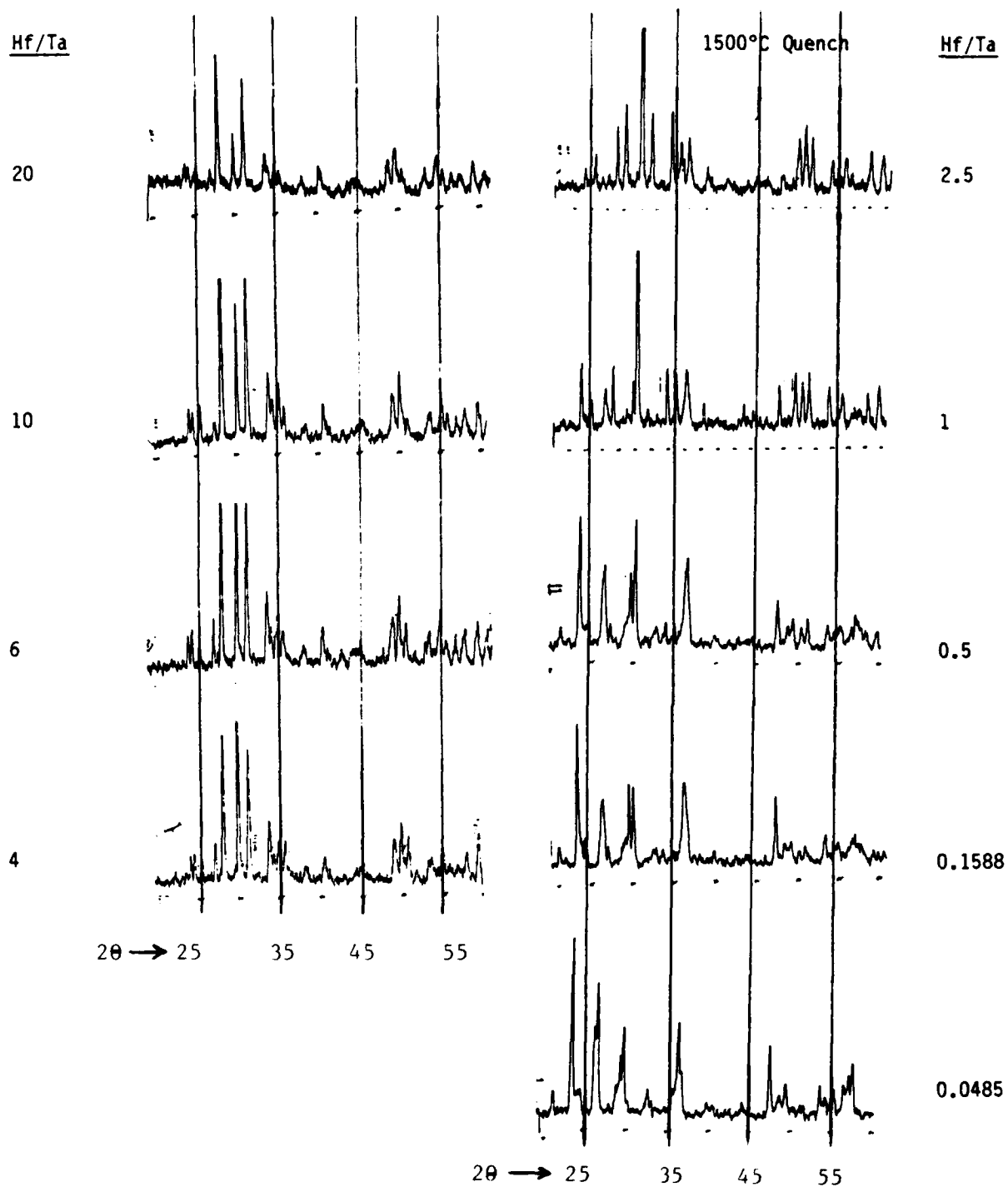


FIGURE 14. XRD TRACES OF SAMPLES  
QUENCHED FROM 1500°C

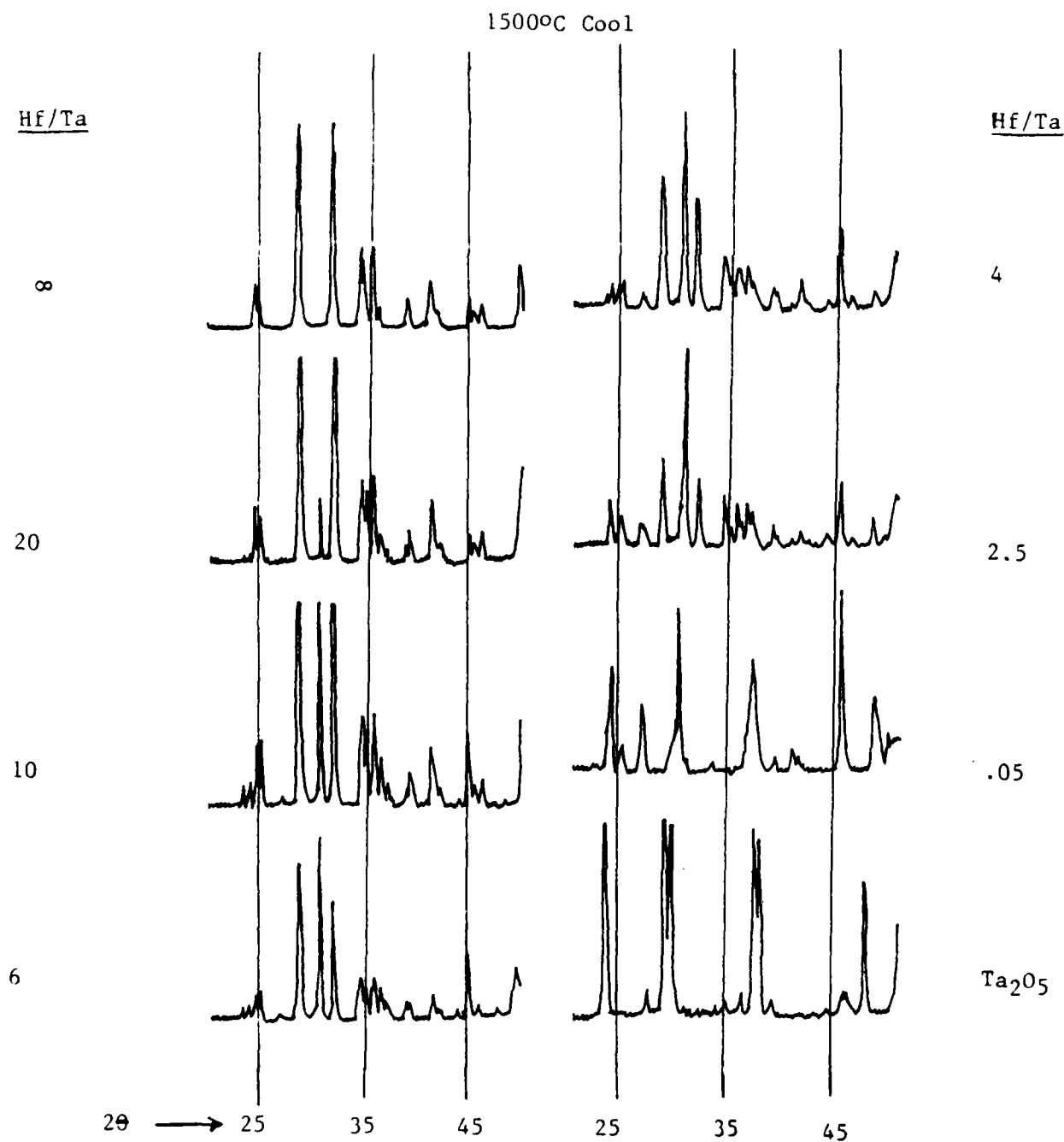


FIGURE 15. XRD TRACES OF SAMPLES  
COOLED FROM 1500°C AT 20°/MIN

TABLE 1. X-Ray Diffraction Determination of  $\text{Hf}_2\text{Ta}_2\text{O}_9$   
(Quenched From 1500°C)

<u>Hf/Ta</u>	<u>Relative Diffraction Intensities</u>			
	<u>HfO<sub>2</sub>*</u>	<u>Hf<sub>2</sub>Ta<sub>2</sub>O<sub>9</sub></u>	<u>%Hf<sub>2</sub>Ta<sub>2</sub>O<sub>9</sub></u>	<u>Hf<sub>2</sub>Ta<sub>2</sub>O<sub>9</sub> Maximum % (Calculated)</u>
$\infty$	50	0	0	0
20	37	3	7	9.5
10	37	10	21	18
6	15	10	40	29
4	12	12	50	40
2.5	8	15	65	71
1.0	1	50	98	100

\*Sum of Primary 2 Reflections

requires extended annealing at lower temperatures. It is also likely that the phases formed by approaching the annealing temperature from low temperature will be different from those observed by cooling from high temperatures unless very long annealing times are used. Clearly, these issues would require work in addition to that so far completed, to be resolved.

#### DIFFUSION COUPLE STUDIES

An original intent of this project was to generate diffusion couple samples which could be studied on a microscale to directly understand

phases formed as a function of composition, through the interface region. Several attempts were made to react polished pellets of the pure oxides at 1700°C, but contact (and pressure which could be applied) were not sufficient. It was found that a very good interface could be established by melting  $\text{Ta}_2\text{O}_5$  onto a polished pellet of  $\text{HfO}_2$ . These could then be annealed to give the desired diffusion zone. We also recognized at this time that hafnium and tantalum x-ray fluorescence peaks are not resolved in the EDS system and concluded



(incorrectly) that quantitative analysis would probably be impossible. Hence, the diffusion couple approach was abandoned in favor of the quench studies reported in the previous sections. In retrospect, having now established that quantitative determination of the Hf/Ta ratio is possible, the diffusion couple approach is still highly attractive and would be a primary emphasis of any continuation of this study.

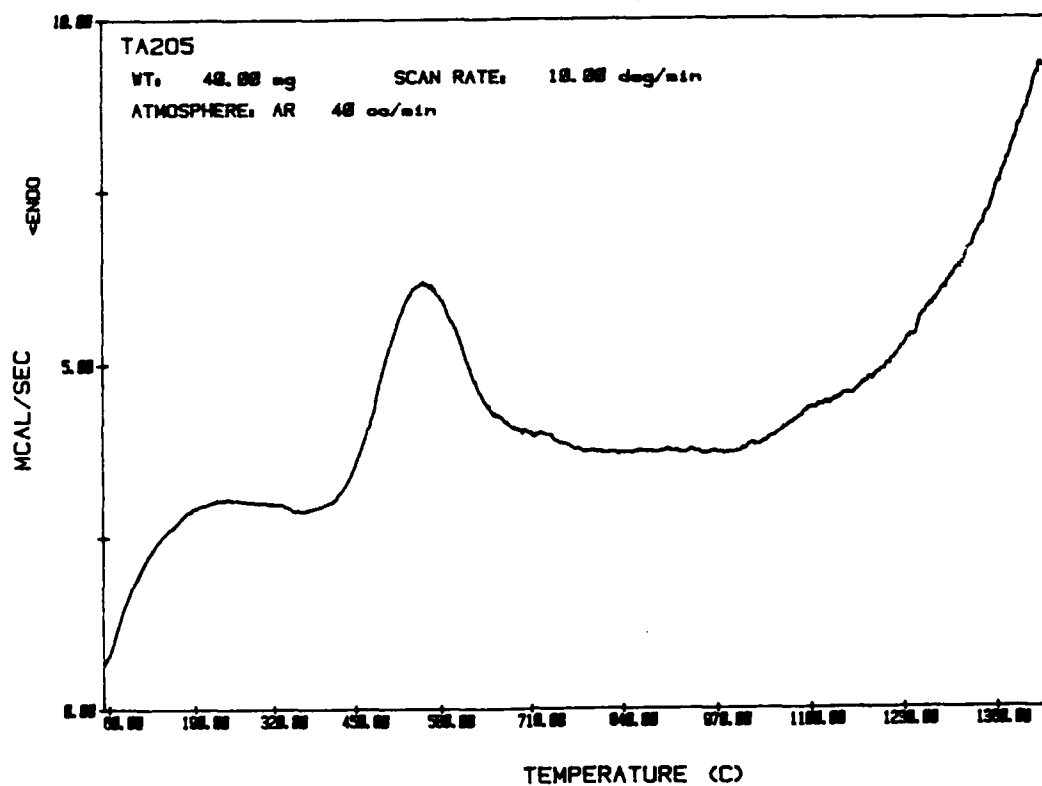
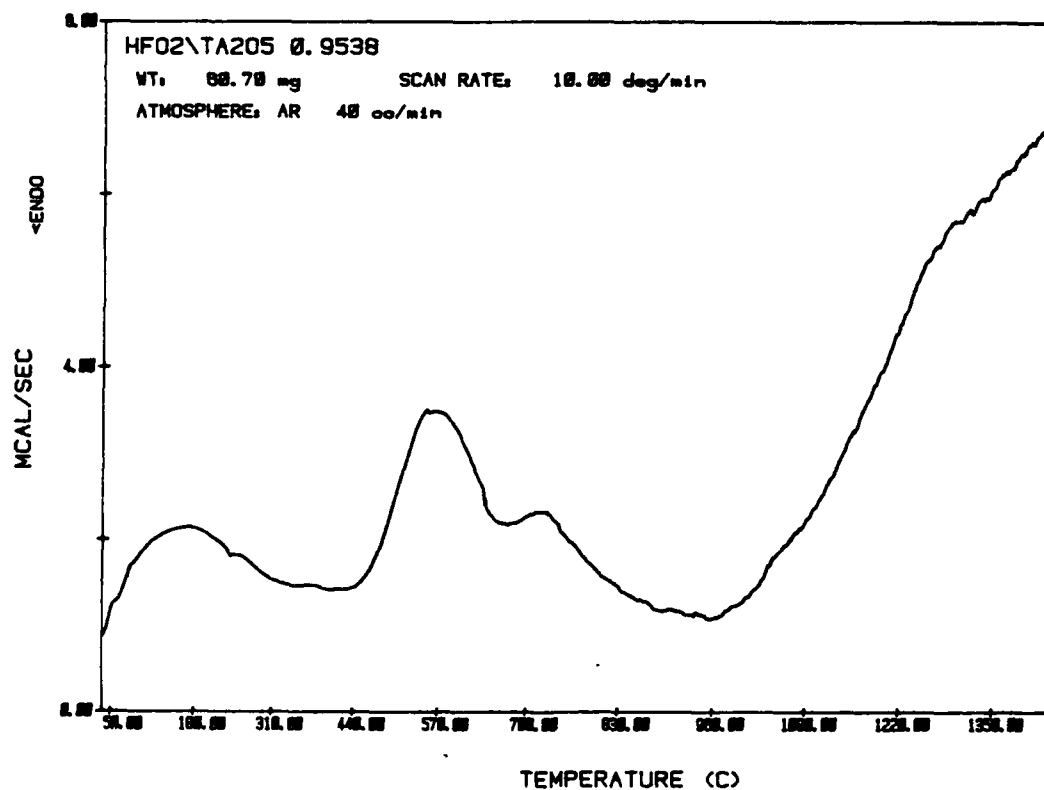
## VOLATILITY

A few limited experiments were conducted to verify that tantalum oxide was not being vaporized rapidly from the molten materials, since this would strongly influence much of this study and might explain (for example) the unexpected x-ray diffraction similarity of a wide range of compositions quenched from the melt. Small beads of pure  $Ta_2O_5$  and  $Hf_2Ta_2O_9$  were maintained in the molten state at as high as  $2300^{\circ}C$  for various times up to about 5 minutes and periodically cooled and weighed. Within experimental error, no weight change was detected. Hence, under the conditions of this study it is believed no significant stoichiometry changes occurred as a result of vaporization losses.

## DIFFERENTIAL THERMAL ANALYSIS

Several experiments were made to determine whether any phase changes in the system might be observable by thermal analysis, although the equipment available is limited to  $1500^{\circ}C$ . The DSC traces are shown as Figures 16-20 for the following materials.

- |           |   |
|-----------|---|
| Figure 16 | Pure $Ta_2O_5$ Fired at $1500^{\circ}C$   |
| Figure 17 | A Physical Mixture $HfO_2/Ta_2O_5 = 0.95$<br>(weight fraction)                                    |
| Figure 18 | Same as 17, but After Heat Treating<br>the Mixture at $1500^{\circ}C$ to Produce<br>$Hf_2Ta_2O_9$ |
| Figure 19 | $1500^{\circ}C$ Fired Material with Weight<br>Ratio at $HfO_2/Ta_2O_5 = 0.238$                    |
| Figure 20 | $1500^{\circ}C$ Fired Material with Weight<br>Ratio at $HfO_2/Ta_2O_5 = 0.1589$                   |

FIGURE 16. DTA TRACE FOR Ta<sub>2</sub>O<sub>5</sub>FIGURE 17. DTA TRACE FOR A PHYSICAL MIXTURE OF HfO<sub>2</sub>/Ta<sub>2</sub>O<sub>5</sub>

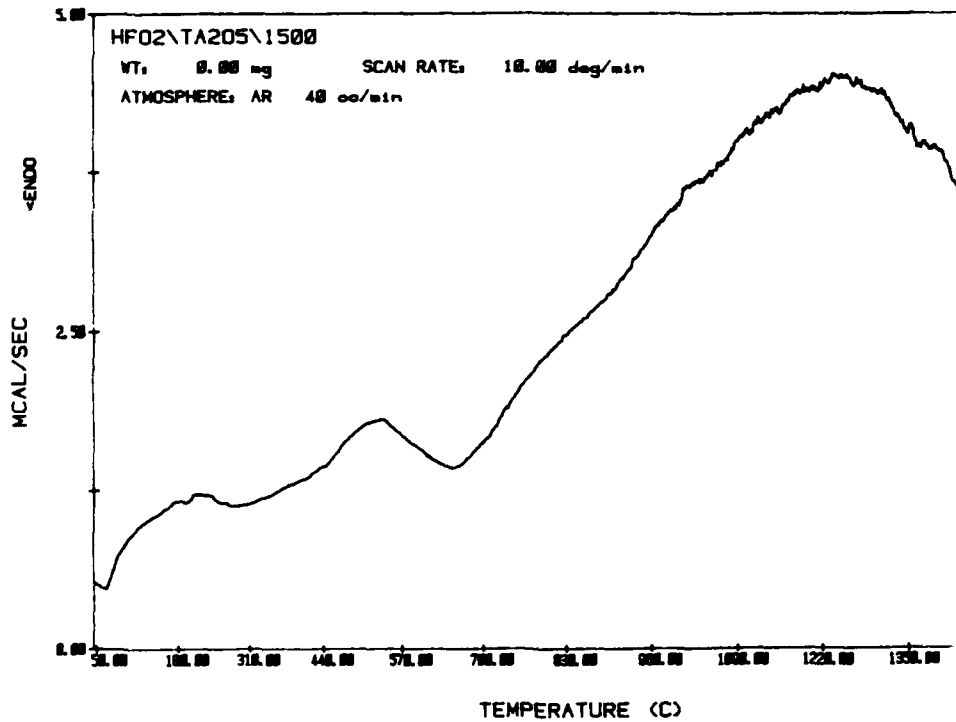


FIGURE 18. DTA TRACE FOR HfO<sub>2</sub>/Ta<sub>2</sub>O<sub>5</sub> AFTER HEAT TREATING THE MIXTURE AT 1500°C TO PRODUCE Hf<sub>2</sub>Ta<sub>2</sub>O<sub>9</sub>

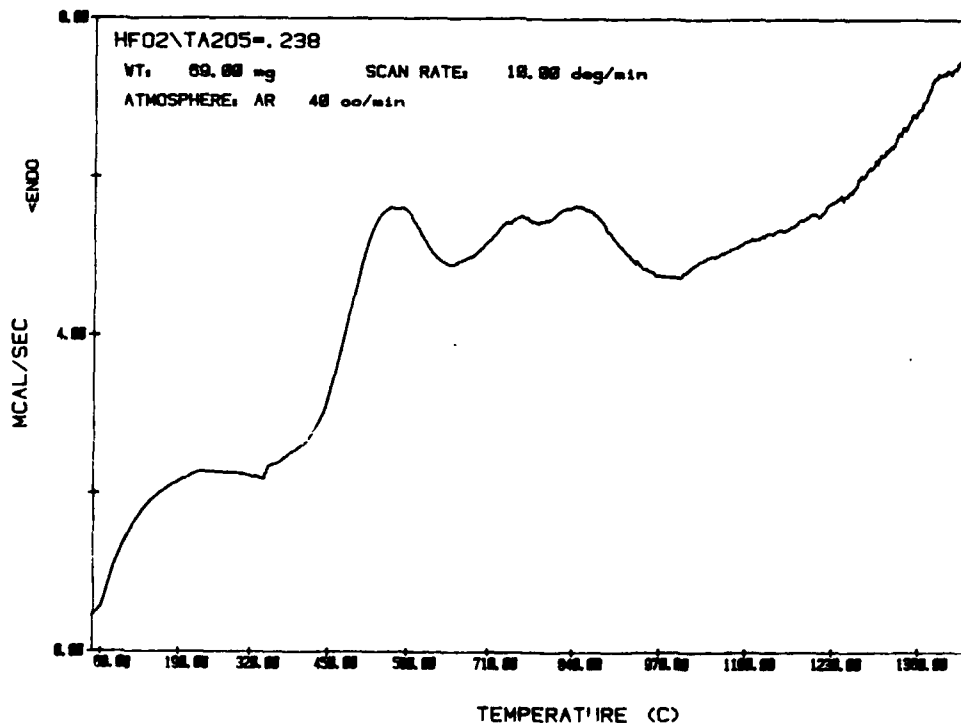


FIGURE 19. DTA TRACE FOR 1500° FIRED MATERIAL WITH WEIGHT RATIO AT HfO<sub>2</sub>/Ta<sub>2</sub>O<sub>5</sub> = 0.238

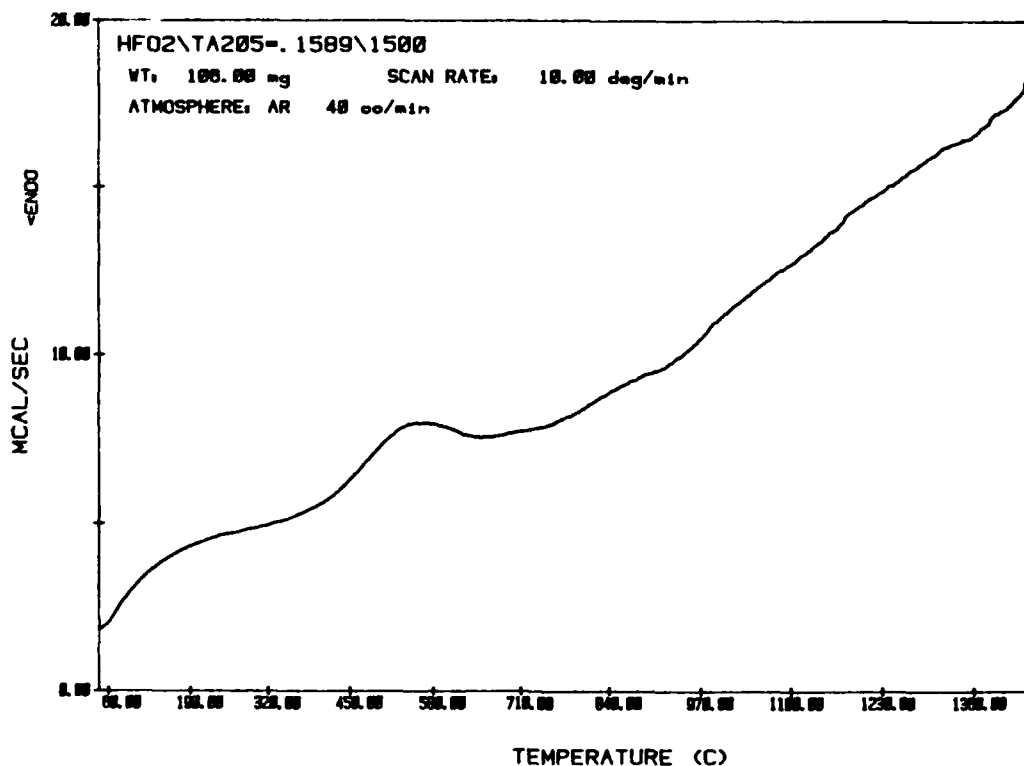


FIGURE 20. DTA TRACE FOR 1500°C FIRED MATERIAL  
 WITH WEIGHT RATIO AT  $\text{HfO}_2/\text{Ta}_2\text{O}_5 = 9.1589$

It first should be noted that any exothermic reactions will be seen in the figures as positive shifts from the baseline. The baseline may also shift gradually as a result of the furnace/thermocouple configuration, having nothing to do with the sample or the reference material ( $\text{Al}_2\text{O}_3$ ). This is especially true at the beginning of the heating cycle. Thus, in Figure 16, the broad exotherm at about 560°C is real and weak, broad exotherms near 700 and 1100°C may be real, but nothing else is of importance. In Figure 17, exotherms at 560°C, 750°C, 1080°C, and 1300°C are all meaningful. The other figures all show thermal excursions that could be studied. Comparing this kind of information to direct structural probes such as high temperature x-ray diffraction, would be required to develop the low temperature portion of the phase diagram. Because of the emphasis in this study on high temperature behavior, the DTA work was not continued even though it is clear much could be learned.

## CONCLUSIONS

The primary conclusions of this Phase I study include the following:

- o The melting temperature of mixed  $\text{HfO}_2$ - $\text{Ta}_2\text{O}_5$  oxides shows a rapid decrease from  $\text{HfO}_2$  at  $2800^\circ\text{C}$  to temperatures at or below  $2200^\circ\text{C}$  with addition of less than 10 mole %  $\text{Ta}_2\text{O}_5$ .
- o All  $\text{Ta}_2\text{O}_5$  rich oxides melt in the range of 1800-2000 $^\circ\text{C}$ .
- o The maximum concentration of  $\text{Ta}_2\text{O}_5$  dissolving in the monoclinic  $\text{HfO}_2$  structure is less than or about 6 wt%, probably as a metastable solid solution.
- o A new phase occurs in samples quenched from the liquid state. It dominates the mixed oxide range from  $\text{Hf}/\text{Ta} = 20$  to  $\text{Hf}/\text{Ta} = 1$ . This phase appears to have a composition with  $\text{Hf}/\text{Ta}$  in the range 2-3.
- o The phase  $\text{Hf}_2\text{Ta}_2\text{O}_9$  appears to have an orthorhombic crystal structure closely related to that reported for a series of more hafnium rich compounds. This phase is very stable with regard to possible reaction with  $\text{HfO}_2$  to form mixed compounds of higher  $\text{HfO}_2$  content. The high temperature region (above  $1500^\circ\text{C}$ ) between  $\text{HfO}_2(\text{ss})$  and this phase appears to remain as a diphasic mixture of these two compounds, in direct relation to the overall sample composition.

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